


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	09/627,725	OYABU ET AL.	
	Examiner	Art Unit	
	Son P. Huynh	2617	

SEARCHED			
Class	Subclass	Date	Examiner
UPDATE	SEARCH	2/22/2006	AH

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST TEXT SEARCH ENCLOSED	2/22/2006	AH